<u>MOSFET</u> – Power, N-Channel 60 V, 46 A, 16 mΩ

Features

- Low Gate Charge
- Fast Switching
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	60	V		
Gate-to-Source Voltag	Gate-to-Source Voltage - Continuous				V
Gate-to-Source Voltage - Non-Repetitive (t _p < 10 μs)			V _{GS}	±30	V
Continuous Drain		$T_C = 25^{\circ}C$	۱ _D	46	А
Current ($R_{\theta JC}$)	Steady	$T_C = 100^{\circ}C$		33	
Power Dissipation $(R_{\theta JC})$	State	$T_C = 25^{\circ}C$	PD	71	W
Pulsed Drain Current	t _p =	= 10 μs	I _{DM}	203	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 175	°C
Source Current (Body I	I _S	46	А		
Single Pulse Drain-to-	E _{AS}	36	mJ		
Avalanche Energy 0.1 mH)			I _{AS}	27	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	49	

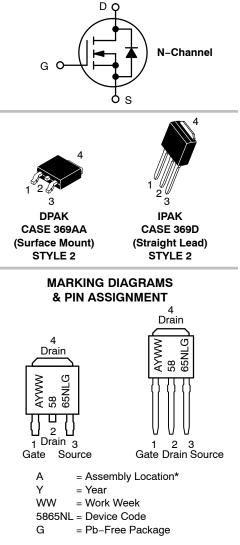
1. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
60 V	$16\mathrm{m}\Omega\ensuremath{@}\xspace10\mathrm{V}$	46 A
60 V	19 mΩ @ 4.5 V	4077



* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

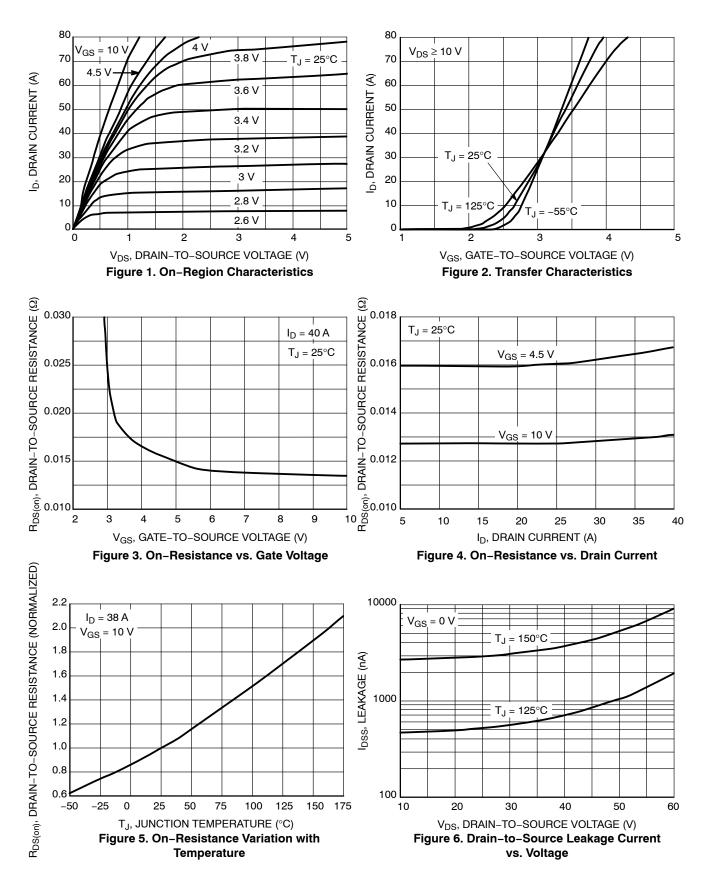
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

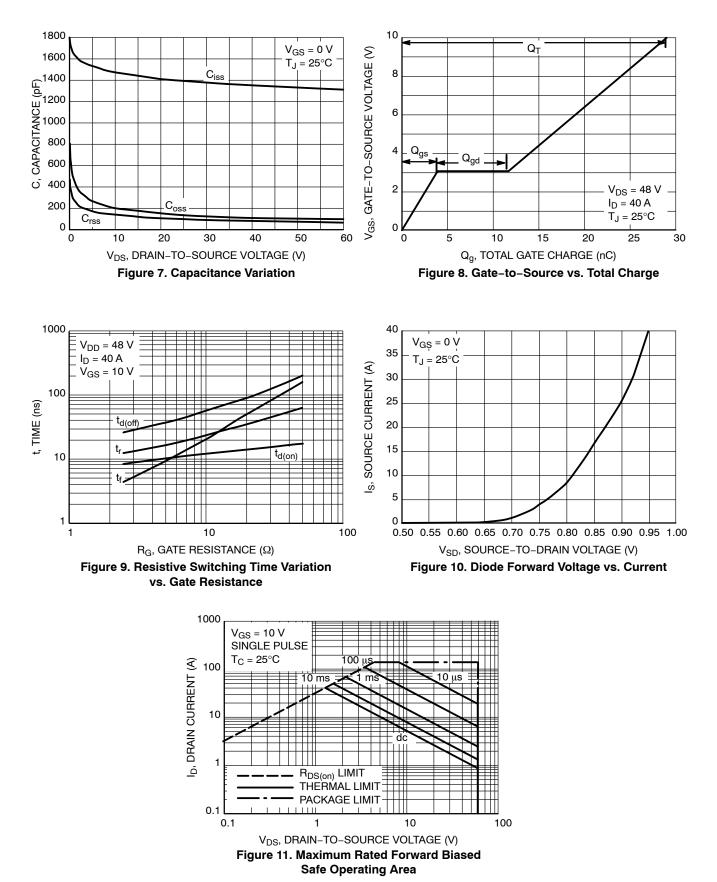
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				55		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 60 V	$T_{J} = 25^{\circ}C$ $T_{J} = 150^{\circ}C$			1.0 100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	-			±100	nA
ON CHARACTERISTICS (Note 2)	ucc		, 				
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D	= 250 μA	1.0		2.0	V
Negative Threshold Temperature Co- efficient	V _{GS(TH)} /T _J		v.		5.6		mV/°C
Drain-to-Source on Resistance	R _{DS(on)}	V _{GS} = 10 V, I _E	₀ = 20 A		13	16	mΩ
Drain-to-Source on Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I	_D = 20 A		16	19	mΩ
Forward Transconductance	gFS	V _{DS} = 15 V, I _E	₀ = 20 A		15		S
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	S					•
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			1400		pF
Output Capacitance	C _{oss}				137		1
Reverse Transfer Capacitance	C _{rss}				95		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V, I _D = 40 A			29		nC
Threshold Gate Charge	Q _{G(TH)}				1.1		
Gate-to-Source Charge	Q _{GS}				4		
Gate-to-Drain Charge	Q _{GD}				8		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} = 48 V, I _D = 40 A			15		nC
Gate Resistance	R _G				1.3		Ω
WITCHING CHARACTERISTICS (Not	e 3)						
Turn–On Delay Time	t _{d(on)}				8.4		ns
Rise Time	t _r	V _{GS} = 10 V, V _D	_D = 48 V,		12.4		
Turn-Off Delay Time	t _{d(off)}	$I_D = 40 \text{ A}, \text{ R}_G$	= 2.5 Ω		26		
Fall Time	t _f				4.4		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.95	1.2	V
			T _J = 125°C		0.85		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, I _S = 40 A			20		ns
Charge Time	ta				13		
Discharge Time	tb				7		
Reverse Recovery Charge	Q _{RR}				13		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

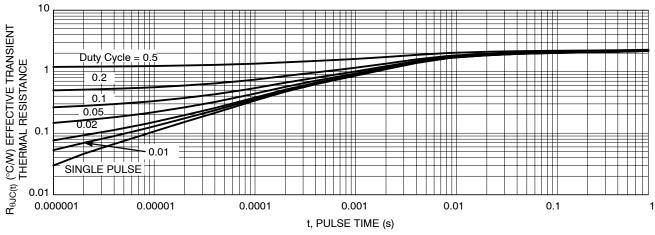


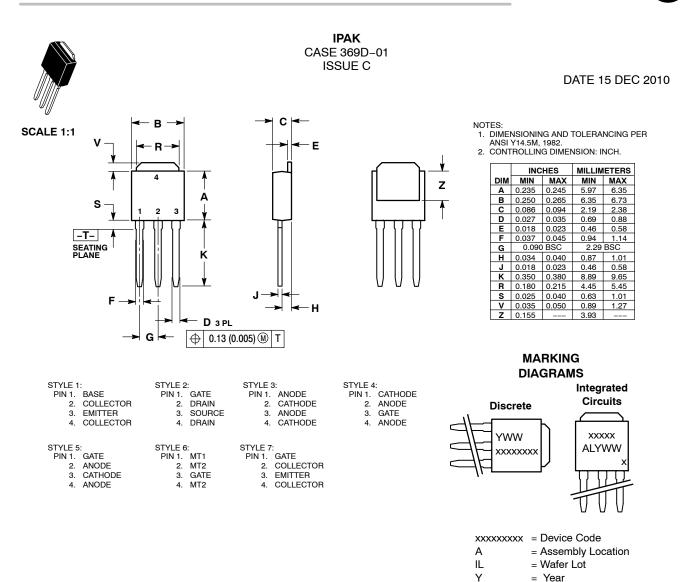
Figure 12. Thermal Response

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD5865NL-1G	IPAK (Straight Lead) (Pb-Free)	75 Units / Rail
NTD5865NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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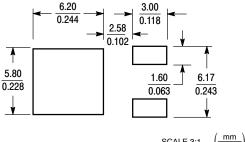
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L3

L4



*For additional information on our Pb-Free strategy and soldering

SCALE 3:1

Inches

details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DATE 03 JUN 2010

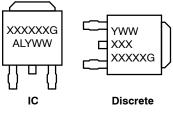
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- 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- THERMAL FAD CONTOR OF FIGURE WITHIN DEMONSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INC	HES	MILLIMETERS		
DIM	MIN MAX		MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
q	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
c	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

MARKING DIAGRAM*



= Device Code = Assembly Location L = Wafer Lot Y = Year = Work Week WW G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

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